

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination YEOW ET AL.	
		Examiner Hashem Farrokh	Art Unit 2187	Page 1 of 1

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*	C	US-5,617,339 a	04-1997	Smith, Gordon J.	702/176
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**NON-PATENT DOCUMENTS**

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